

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10644009	TAKEUCHI ET AL.
	Examiner	Art Unit
	Tran, Philip B	2155

SEARCHED			
Class	Subclass	Date	Examiner
709	245, 242, 238, 225, 227-228, 230	6/20/2007	PBT
370	392-393, 466, 389,400	6/20/2007	PBT

SEARCH NOTES			
Search Notes	Date	Examiner	
East and NPL	6/20/07	PBT	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner